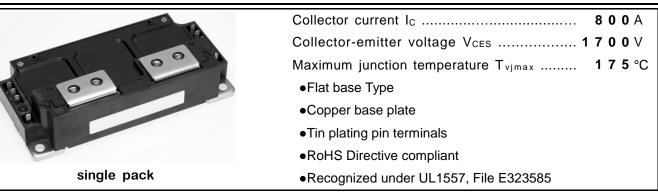


<IGBT Modules>

CM800HA-34S

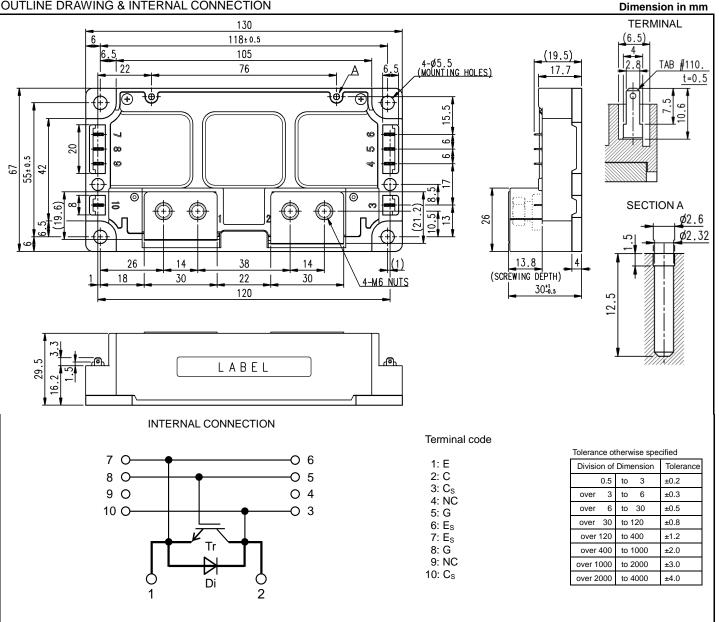
HIGH POWER SWITCHING USE INSULATED TYPE



APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, Photovoltaic power, Wind power, etc.

OUTLINE DRAWING & INTERNAL CONNECTION



1

MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit	
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V	
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V	
Ic	Collector current	DC, T _C =111 °C (Note2, 4)	800		
I _{CRM}	Collector current	Pulse, Repetitive (Note3)	1600	A	
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	5700	W	
IE (Note1)	Emitter current	DC (Note2)	800	^	
IERM (Note1)	Emilier current	Pulse, Repetitive (Note3)	1600	A	
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V	
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C	
T _{Cmax}	Maximum case temperature	(Note4)	125		
T_{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C	
T _{stg}	Storage temperature	-	-40 ~ +125		

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Symbol	Item Conditions			Limits			Unit
Symbol				Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I _C =80 mA, V _{CE} =10 V		5.4	6.0	6.6	V
		I _C =800 A, V _{GE} =15 V,	T _{vj} =25 °C	-	2.10	2.60	V
V _{CEsat}		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.35	-	
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.45	-	
	Collector-emitter saturation voltage	I _C =800 A,	T _{vj} =25 °C	-	2.00	2.50	
V _{CEsat}		V _{GE} =15 V,	T _{vj} =125 °C	-	2.25	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.35	-	
Cies	Input capacitance			-	-	185	nF
C _{oes}	Output capacitance	V _{CE} =10 V, G-E short-circuited	V _{CE} =10 V, G-E short-circuited		-	19.5	
Cres	Reverse transfer capacitance			-	-	3.5	
Q _G	Gate charge	V _{CC} =1000 V, I _C =800 A, V _{GE} =15 V		-	3.36	-	μC
t _{d(on)}	Turn-on delay time	$V_{CC}{=}1000$ V, $I_{C}{=}800$ A, $V_{GE}{=}{\pm}15$ V, $R_{G}{=}0$ $\Omega,$ Inductive load		-	-	900	- ns
tr	Rise time			-	-	300	
$t_{d(off)}$	Turn-off delay time			-	-	900	
t _f	Fall time			-	-	400	
		I _E =800 A, G-E short-circuited,	T _{vi} =25 °C	-	2.10	2.60	
V _{EC} (Note.1)		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.20	-	V
(Terminal)		(Note5)	T _{vi} =150 °C	-	2.15	-	
	Emitter-collector voltage	I _E =800 A,	T _{vi} =25 °C	-	2.00	2.50	
V _{EC} ^(Note.1)		G-E short-circuited,	T _{vj} =125 °C	-	2.10	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.05	-	
trr (Note1)	Reverse recovery time	V _{CC} =1000 V, I _E =800 A, V _{GE} =±15 V,		-	-	500	ns
Qrr (Note1)	Reverse recovery charge	$R_{G}=0$ Ω, Inductive load		-	160	-	μC
Eon	Turn-on switching energy per pulse	$V_{CC}=1000 \text{ V}, I_{C}=I_{E}=800 \text{ A},$ $V_{GE}=\pm 15 \text{ V}, R_{G}=0 \Omega, T_{v_{1}}=150 \text{ °C},$		-	392	-	
E _{off}	Turn-off switching energy per pulse			-	200	-	mJ
Err (Note1)	Reverse recovery energy per pulse	Inductive load		-	199	-	mJ
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, Tc=25 °C (Note4)		-	0.2	-	mΩ
r _g	Internal gate resistance	- -		-	2.75	-	Ω
					1		

<IGBT Modules> CM800HA-34S HIGH POWER SWITCHING USE INSULATED TYPE

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance	Junction to case, IGBT (Note4)	-	-	26.3	K/kW
R _{th(j-c)D}		Junction to case, FWD (Note4)	-	-	40	r/kvv
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, Thermal grease applied ^(Note4, 6)	-	18	-	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit	
				Min.	Тур.	Max.	Unit	
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m	
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m	
d	Creepage distance	Terminal to terminal		22.0	-	-	mm	
ds		Terminal to base plate		21.9	-	-		
da	Clearance	Terminal to terminal		16.5	-	-	mm	
		Terminal to base plate		12.5	-	-		
ec	Flatness of base plate	On the centerline X, Y (Note7)		-50	-	+100	μm	
m	mass	-		-	490	-	g	

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU. Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature (T_{vj}) should not exceed T_{vjmax} rating.

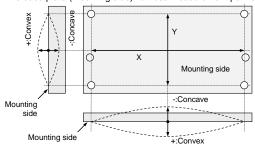
3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.

4. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K)/D_(C-S)=100 µm.

7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



8. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

The length of the screw depends on the PCB thickness (t1.0).

	Туре	Size	Tightening torque	Recommended tightening method					
(1)	PT®	K25×8	0.55 ± 0.055 N∙m						
(2)	PT®	K25×10	0.85 ± 0.085 N∙m	by handwork (equivalent to 30 r/min					
(3)	DELTA PT®	25×8	0.55 ± 0.055 N∙m	by mechanical screw driver)					
(4)	DELTA PT®	25×10	0.85 ± 0.085 N∙m	~ 600 r/min (by mechanical screw driver)					
(5)	B1 tapping screw	φ2.6×10 or φ2.6×12	0.85 ± 0.085 N∙m						

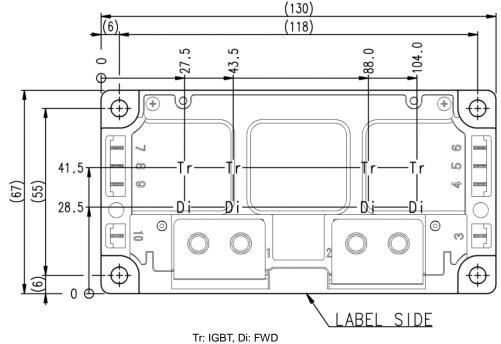
<IGBT Modules> CM800HA-34S HIGH POWER SWITCHING USE

INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
		Conditions	Min.	Тур.	Max.	Unit
V _{cc}	(DC) Supply voltage	Applied across C-E terminals	-	1000	1200	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G-Es terminals	13.5	15.0	16.5	V
R _G	External gate resistance	-	0	-	15	Ω

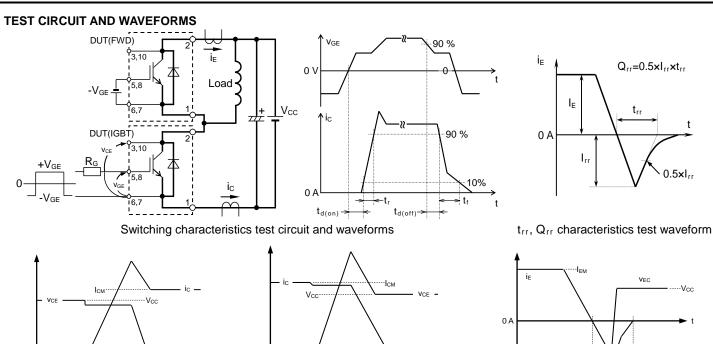
CHIP LOCATION (Top view)



Dimension in mm, tolerance: ±1 mm

<IGBT Modules> CM800HA-34S

HIGH POWER SWITCHING USE INSULATED TYPE



0.1×Vcc

 t_i IGBT Turn-on switching energy

IGBT Turn-off switching energy

0.02×IcN

FWD Reverse recovery energy

ti

0.5×l_{rr}

-Vcc

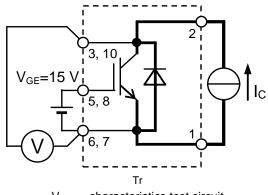
Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

 t_i

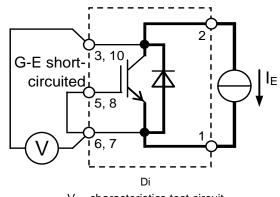
TEST CIRCUIT

Λ

0.1×lc



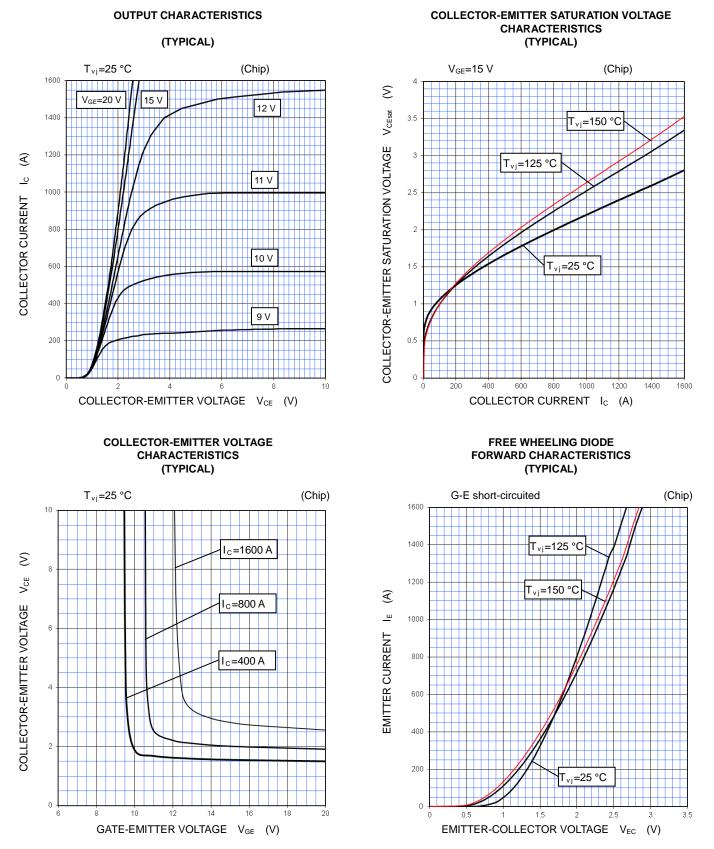
V_{CEsat} characteristics test circuit



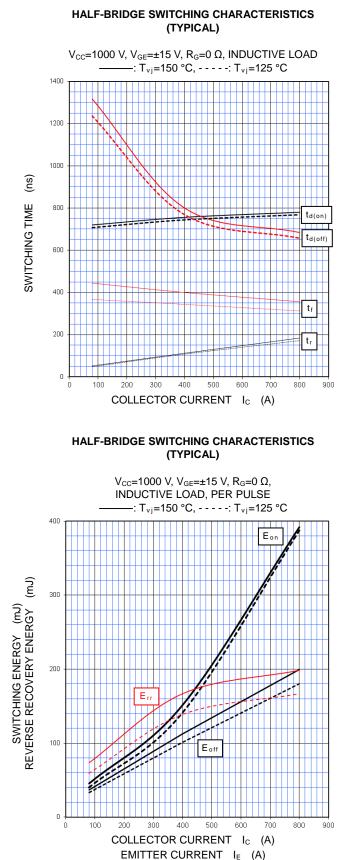
0 V

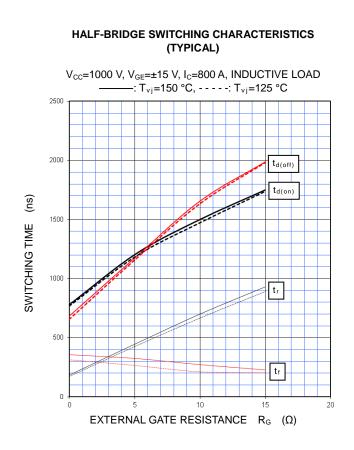
V_{EC} characteristics test circuit

PERFORMANCE CURVES

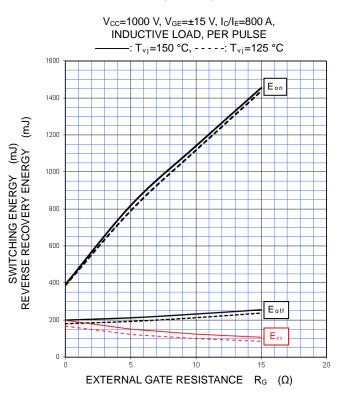


PERFORMANCE CURVES





HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



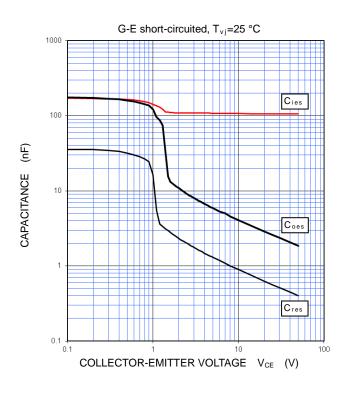
<IGBT Modules> CM800HA-34S

HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES



(TYPICAL)

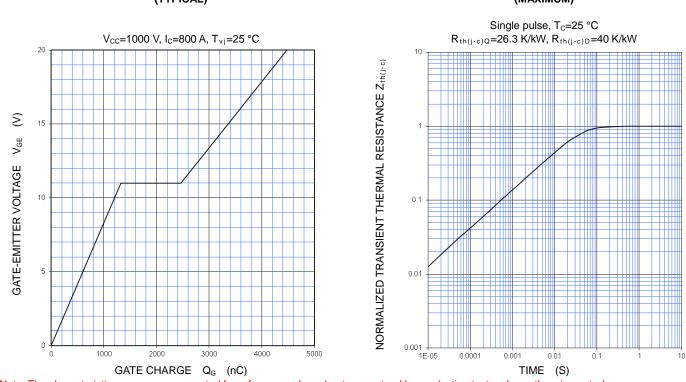


GATE CHARGE CHARACTERISTICS (TYPICAL)

REVERSE RECOVERY CHARACTERISTICS (TYPICAL) V_{CC} =1000 V, V_{GE} =±15 V, R_{G} =0 Ω , INDUCTIVE LOAD -: T_{vj}=150 °C, - - - -: T_{vj}=125 °C 1000 800 trr € 600 (ns), I_{rr} 400 ŗ Irr 200 O 200 100 300 400 500 700 800 900 600 0 EMITTER CURRENT (A) ΙE

FREE WHEELING DIODE

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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